









REF3012, REF3020, REF3025, REF3030, REF3033, REF3040

20

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SBVS032H-MARCH 2002-REVISED FEBRUARY 2018

REF30xx 50-ppm/°C Max, 50-μA, CMOS Voltage Reference in SOT-23-3

1 Features

- microSize Package: SOT-23-3
- Low Dropout: 1 mV
- High Output Current: 25 mA
- High Accuracy: 0.2%
- Low I_Ω: 42 μA (Typical)
- Excellent Specified Drift Performance:
 - 50 ppm/°C (Maximum) From 0°C to 70°C
 - 75 ppm/°C (Maximum) From -40°C to +125°C

2 Applications

- Temperature and Pressure Transmitters
- Portable, Battery-Powered Equipment
- Data Acquisition Systems
- Medical Equipment
- Handheld Test Equipment

3 Description

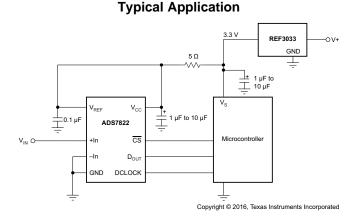
The REF30xx is a precision, low-power, low-dropout voltage, reference family available in a tiny 3-pin SOT-23 package. The REF30xx offers excellent temperature drift and initial accuracy while operating at a quiescent current of 42 μ A (typical).

The low power consumption and the relatively high precision make the REF30xx very attractive for looppowered industrial applications such as pressure and temperature transmitter applications. The REF30xx is easy to use in intrinsically safe and explosion-proof applications because it does not require a load capacitor to be stable. The REF30xx is specified over the extended industrial temperature range of -40° C to +125°C.

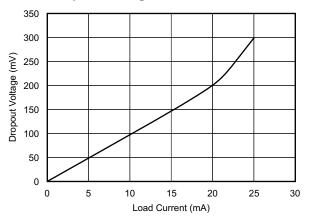
The REF30xx operates with supplies within 1 mV of output voltage under zero-load conditions. Engineers can use the low dropout, small size, and low power consumption of the REF30xx in portable and battery-powered applications.

Device Information

PART NUMBER	PACKAGE	BODY SIZE (NOM)
REF30xx	SOT-23 (3)	2.92 mm × 1.30 mm



Dropout Voltage vs Load Current





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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision G (November 2015) to Revision H

•	Changed section header From: REF33xx (REF3312, REF3318, REF3320, REF3325, REF3330, REF3333) To:	
	REF30xx (REF3012, REF3020, REF3025, REF3030, REF30333, REF3040) in the <i>Electrical Characteristics</i>	6
•	Added turnon settling time TYP value of 120 µs (deleted by mistake in the previous revision)	6
•	Added NOTE to the Application and Implementation section	15

Changes from Revision F (August 2008) to Revision G

•	Added Device Information, ESD Ratings, Recommended Operating Conditions, and Thermal Information tables	. 1
•	Added Detailed Description, Applications and Implementation, Power-Supply Recommendations, Layout, Device and Documentation Support, and Mechanical, Packaging, and Orderable Information sections	. 1
•	Changed text in Description section	1
•	Deleted thermal resistance parameter in Electrical Characteristics; see new Thermal Information table	6
•	Moved temperature parameters from Electrical Characteristics to Recommended Operating Conditions	6

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Product Folder Links: REF3012 REF3020 REF3025 REF3030 REF3033 REF3040

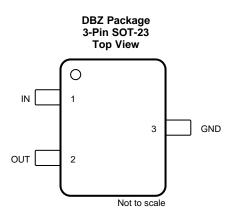
2



5 Device Comparison Table

PART NUMBER	VOLTAGE (V)
REF3012	1.25
REF3020	2.048
REF3025	2.5
REF3030	3.0
REF3033	3.3
REF3040	4.096

6 Pin Configuration and Functions



Pin Functions

PIN		1/0	DESCRIPTION		
NO.	NAME	I/O	DESCRIPTION		
1	IN	Input	Input supply voltage		
2	OUT	Output	Reference output voltage		
3	GND		Ground		

7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

	MIN	MAX	UNIT
Supply voltage, V+ to V-		7.0	V
Output short-circuit current ⁽²⁾		Continuous	
Operating temperature	-40	125	°C
Junction temperature		150	°C
Storage temperature, T _{stg}	-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) Short circuit to ground.

7.2 ESD Ratings

			VALUE	UNIT
V	Flastrastatia discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±4000	V
V _(ESD)	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1500	v

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

at $T_A = 25^{\circ}C$, $V_{IN} = 5$ V, and $I_{LOAD} = 0$ mA (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V _{IN}	Input voltage	V _{REF} + 0.05 ⁽¹⁾		5.5	V
I _{LOAD}	Load current			25	mA
T _A	Operating temperature	-40		125	°C

(1) For $I_L > 0$, see *Typical Characteristics*. Minimum supply voltage for REF3012 is 1.8 V.

7.4 Thermal Information

		REF30xx	
	THERMAL METRIC ⁽¹⁾	DBZ (SOT-23)	UNIT
		3 PINS	
$R_{ hetaJA}$	Junction-to-ambient thermal resistance	297.3	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	128.5	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	91.7	°C/W
ΨJT	Junction-to-top characterization parameter	12.8	°C/W
Ψјв	Junction-to-board characterization parameter	90.3	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

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7.5 Electrical Characteristics

at T_{A} = 25°C, V_{IN} = 5 V, and I_{LOAD} = 0 mA (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
REF3012	(1.25 V) ⁽¹⁾				·	
V _{OUT}	Output voltage		1.2475	1.25	1.2525	V
	Initial accuracy				0.2%	
		f = 0.1 Hz to 10 Hz		14		μV_{PP}
	Output voltage noise	f = 10 Hz to 10 kHz		42		μVrms
	Line regulation	$1.8 \text{ V} \leq \text{V}_{\text{IN}} \leq 5.5 \text{ V}$		60	190	μV/V
REF3020	(2.048 V)	· · · · · ·			·	
V _{OUT}	Output voltage		2.044	2.048	2.052	V
	Initial accuracy				0.2%	
		f = 0.1 Hz to 10 Hz		23		μV_{PP}
	Output voltage noise	f = 10 Hz to 10 kHz		65		μVrms
	Line regulation	V_{REF} + 50 mV $\leq V_{IN} \leq$ 5.5 V		110	290	μV/V
REF3025	(2.5 V)					
V _{OUT}	Output voltage		2.495	2.50	2.505	V
	Initial accuracy				0.2%	
		f = 0.1 Hz to 10 Hz		28		μV_{PP}
	Output voltage noise	f = 10 Hz to 10 kHz		80		μVrms
	Line regulation	V_{REF} + 50 mV $\leq V_{IN} \leq$ 5.5 V		120	325	μV/V
REF3030	(3.0 V)					
V _{OUT}	Output voltage		2.994	3.0	3.006	V
	Initial accuracy				0.2%	
	Output welterer reier	f = 0.1 Hz to 10 Hz		33		μV_{PP}
	Output voltage noise	f = 10 Hz to 10 kHz		94		μVrms
	Line regulation	V_{REF} + 50 mV $\leq V_{IN} \leq$ 5.5 V		120	375	μV/V
REF3033	(3.3 V)	· · · · ·			·	
V _{OUT}	Output voltage		3.294	3.30	3.306	V
	Initial accuracy				0.2%	
	Output welterer reier	f = 0.1 Hz to 10 Hz		36		μV_{PP}
	Output voltage noise	f = 10 Hz to 10 kHz		105		μVrms
	Line regulation	V_{REF} + 50 mV $\leq V_{IN} \leq$ 5.5 V		130	400	μV/V
REF3040	(4.096 V)					
V _{OUT}	Output voltage		4.088	4.096	4.104	V
	Initial accuracy				0.2%	
	Output welterer reside	f = 0.1 Hz to 10 Hz		45		μV_{PP}
	Output voltage noise	f = 10 Hz to 10 kHz		128		μVrms
	Line regulation	V_{REF} + 50 mV $\leq V_{IN} \leq$ 5.5 V		160	410	μV/V

(1) The minimum supply voltage for the REF3012 is 1.8 V.

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Electrical Characteristics (continued)

at $T_A = 25^{\circ}C$, $V_{IN} = 5$ V, and $I_{LOAD} = 0$ mA (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	ТҮР	MAX	UNIT	
REF30xx (F	REF3012, REF3020, REF3025, REF30	30, REF30333, REF3040)					
		$0^{\circ}C \le T_A \le 70^{\circ}C$		20	50		
a\/ /aT	Output voltage temperature drift(2)	$-30^{\circ}C \le T_{A} \le +85^{\circ}C$		28	60	nnm/%C	
dV _{OUT} /dT	Output voltage temperature drift ⁽²⁾	$-40^{\circ}C \le T_{A} \le +85^{\circ}C$	C ≤ T _A ≤ +85°C		65	ppm/°C	
	$-40^{\circ}C \le T_{A} \le +125^{\circ}C$		35	75			
		0000h to 1000h		24			
	Long-term stability	1000h to 2000h		15		ppm	
$\Delta V_{O(\Delta IL)}$	Load regulation ⁽³⁾	$0 \text{ mA} < I_{\text{LOAD}} < 25 \text{ mA}, V_{\text{IN}} = V_{\text{REF}} + 500 \text{ mV}^{(1)}$		3	100	µV/mA	
dT	Thermal hysteresis ⁽⁴⁾			25	100	ppm	
$V_{IN} - V_{OUT}$	Dropout voltage			1	50	mV	
I _{SC}	Short-circuit current			45		mA	
	Turnon settling time	To 0.1% with $C_L = 1 \ \mu F$		120		μs	
POWER SU	IPPLY						
	Quiese and summert			42	50	•	
lq	Quiescent current	$-40^{\circ}C \le T_A \le +125^{\circ}C$			59	μA	

(2) Box method used to determine over temperature drift.

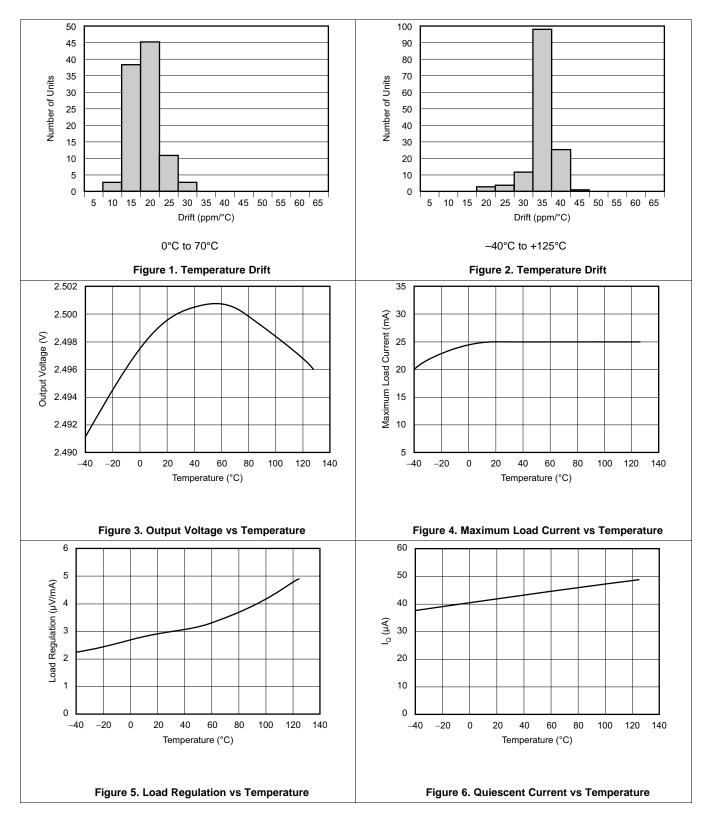
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 (3) Typical value of load regulation reflects measurements using a force and sense conta
 (4) Thermal hysteresis procedure explained in more detail in *Thermal Hysteresis* section. Typical value of load regulation reflects measurements using a force and sense contacts; see Load Regulation section.



7.6 Typical Characteristics

at $T_A = 25^{\circ}C$, $V_{IN} = 5$ V, and REF3025 used for typical characteristics (unless otherwise noted)

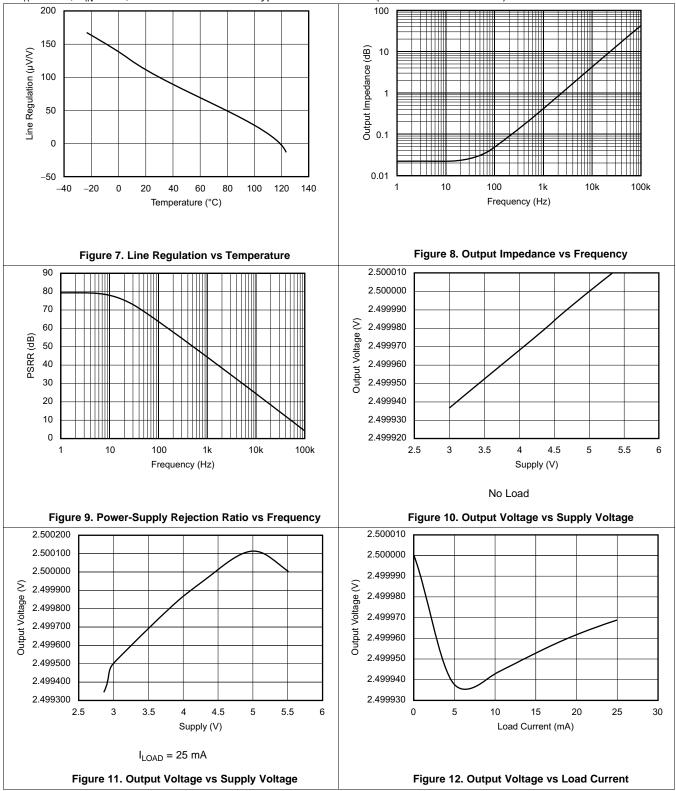


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Typical Characteristics (continued)



at $T_A = 25^{\circ}$ C, $V_{IN} = 5$ V, and REF3025 used for typical characteristics (unless otherwise noted)

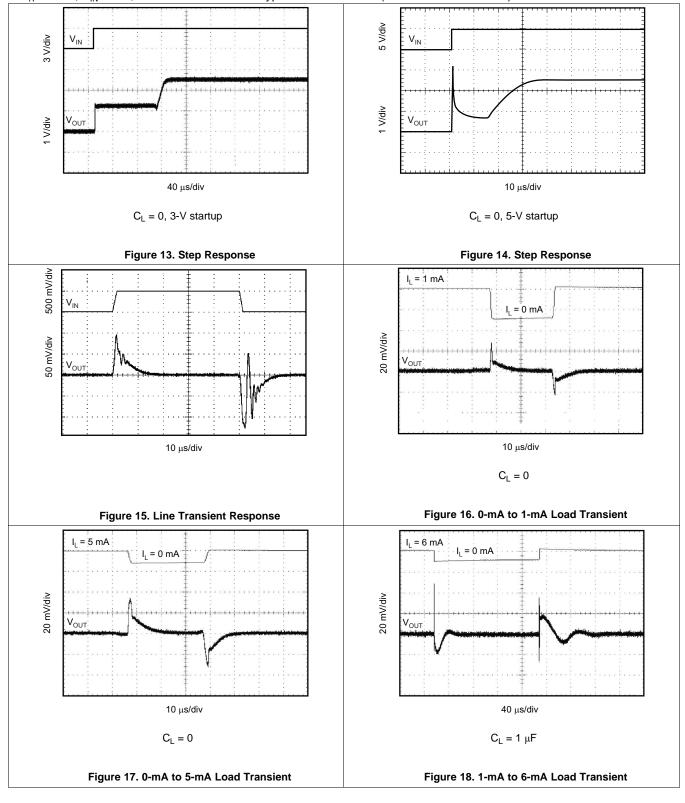
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Typical Characteristics (continued)

at $T_A = 25^{\circ}C$, $V_{IN} = 5$ V, and REF3025 used for typical characteristics (unless otherwise noted)

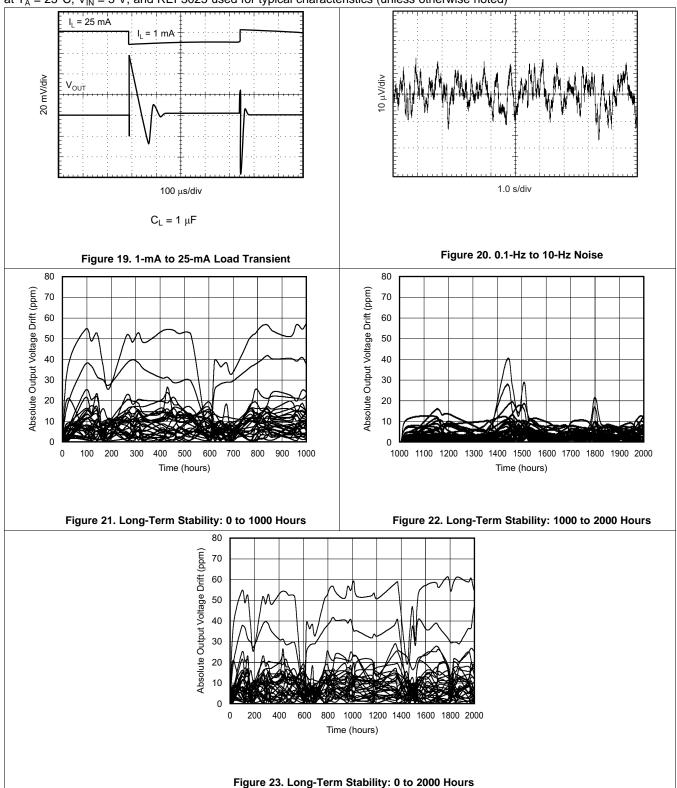


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Typical Characteristics (continued)



at T_A = 25°C, V_{IN} = 5 V, and REF3025 used for typical characteristics (unless otherwise noted)

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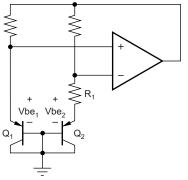


8 Detailed Description

8.1 Overview

The REF30xx is a series, CMOS, precision bandgap voltage reference. Its basic topology is shown in the *Functional Block Diagram* section. Transistors Q_1 and Q_2 are biased so that the current density of Q_1 is greater than that of Q_2 . The difference of the two base-emitter voltages, Vbe₁ – Vbe₂, has a positive temperature coefficient and is forced across resistor R_1 . This voltage is gained up and added to the base-emitter voltage of Q_2 , which has a negative coefficient. The resulting output voltage is virtually independent of temperature. The curvature of the bandgap voltage, as shown in Figure 3, is due to the slightly nonlinear temperature coefficient of the base-emitter voltage of Q_2 .

8.2 Functional Block Diagram



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8.3 Feature Description

8.3.1 Supply Voltage

The REF30xx family of references features an extremely low dropout voltage. With the exception of the REF3012, which has a minimum supply requirement of 1.8 V, the REF30xx can be operated with a supply of only 1 mV above the output voltage in an unloaded condition. For loaded conditions, a typical dropout voltage versus load is shown on the front page.

The REF30xx features a low quiescent current that is extremely stable over changes in both temperature and supply. The typical room temperature quiescent current is 42 μ A, and the maximum quiescent current over temperature is just 59 μ A. Additionally, the quiescent current typically changes less than 2.5 μ A over the entire supply range, as shown in Figure 24.

Supply voltages below the specified levels can cause the REF30xx to momentarily draw currents greater than the typical quiescent current. Use a power supply with a fast rising edge and low output impedance to easily prevent this issue.



Feature Description (continued)

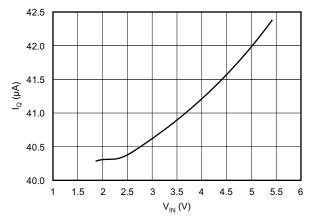


Figure 24. Supply Current vs Supply Voltage

8.3.2 Thermal Hysteresis

Thermal hysteresis for the REF30xx is defined as the change in output voltage after operating the device at 25°C, cycling the device through the specified temperature range, and returning to 25°C, and can be expressed as shown in Equation 1:

$$V_{HYST} = \left(\frac{abs|V_{PRE} - V_{POST}|}{V_{NOM}}\right) \cdot 10^6 \text{ (ppm)}$$

where

- V_{HYST} = Calculated hysteresis
- V_{PRE} = Output voltage measured at 25°C pretemperature cycling
- V_{POST} = Output voltage measured when device has been operated at 25°C, cycled through specified range of -40°C to +125°C, and returned to operation at 25°C. (1)

8.3.3 Temperature Drift

The REF30xx exhibits minimal drift error, defined as the change in output voltage over varying temperature. Using the *box* method of drift measurement, the REF30xx features a typical drift coefficient of 20 ppm from 0°C to 70°C, the primary temperature range of use for many applications. For industrial temperature ranges of –40°C to +125°C, the REF30xx family drift increases to a typical value of 50 ppm.

8.3.4 Noise Performance

The REF30xx generates noise less than 50 μ V_{PP} between frequencies of 0.1 Hz to 10 Hz, and can be seen in Figure 20 The noise voltage of the REF30xx increases with output voltage and operating temperature. Additional filtering may be used to improve output noise levels; however, ensure the output impedance does not degrade AC performance.

8.3.5 Long-Term Stability

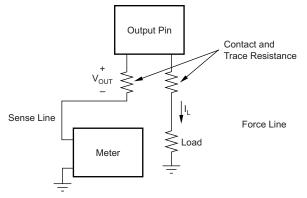
Long-term stability refers to the change of the output voltage of a reference over a period of months or years. This effect lessens as time progresses as is apparent by the long-term stability curves. The typical drift value for the REF30xx is 24 ppm from 0 hours to 1000 hours, and 15 ppm from 1000 hours to 2000 hours. This parameter is characterized by measuring 30 units at regular intervals for a period of 2000 hours.



Feature Description (continued)

8.3.6 Load Regulation

Load regulation is defined as the change in output voltage as a result of changes in load current. Load regulation for the REF30xx is measured using force and sense contacts as shown in Figure 25. The force and sense lines tied to the contact area of the output pin reduce the impact of contact and trace resistance, resulting in accurate measurement of the load regulation contributed solely by the REF30xx. For applications requiring improved load regulation, use force and sense lines.



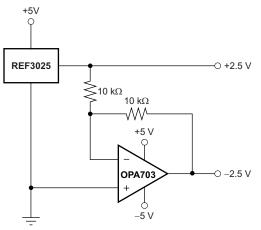
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Figure 25. Accurate Load Regulation of REF30xx

8.4 Device Functional Modes

8.4.1 Negative Reference Voltage

For applications requiring a negative and positive reference voltage, the OPA703 and REF30xx can be used to provide a dual-supply reference from a \pm 5-V supply. Figure 26 shows the REF3025 used to provide a \pm 2.5-V supply reference voltage. The low offset voltage and low drift of the OPA703 complement the low drift performance of the REF30xx to provide an accurate solution for split-supply applications.



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Figure 26. REF3025 Combined With OPA703 to Create Positive and Negative Reference Voltages.

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Device Functional Modes (continued)

8.4.2 Data Acquisition

Often data acquisition systems require stable voltage references to maintain necessary accuracy. The REF30xx family features stability and a wide range of voltages suitable for most microcontrollers and data converters. Figure 27 and Figure 28 show two basic data acquisition systems.

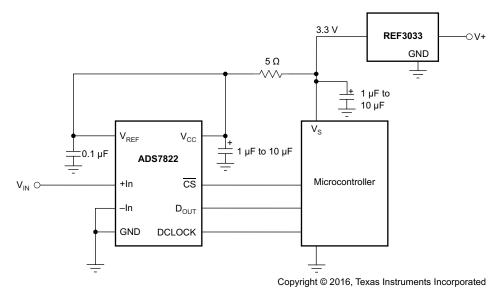


Figure 27. Basic Data Acquisition System 1

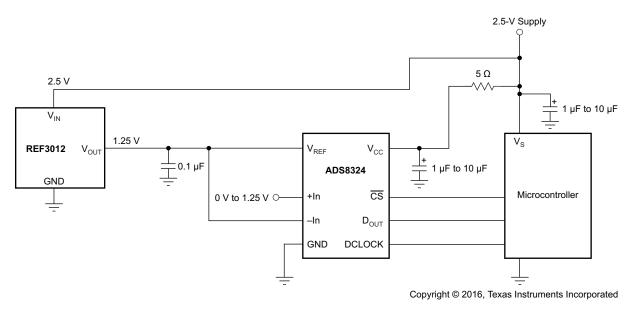


Figure 28. Basic Data Acquisition System 2

Product Folder Links: REF3012 REF3020 REF3025 REF3030 REF3033 REF3040



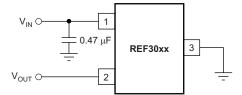
9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

For normal operation, the REF30xx does not require a capacitor on the output. If a capacitive load is connected, take special care when using low equivalent series resistance (ESR) capacitors and high capacitance. This precaution is especially true for low-output voltage devices; therefore, for the REF3012 use a low-ESR capacitance of 10 μ F or less. Figure 29 shows the typical connections required for operation of the REF30xx. A supply bypass capacitor of 0.47 μ F is always recommended.

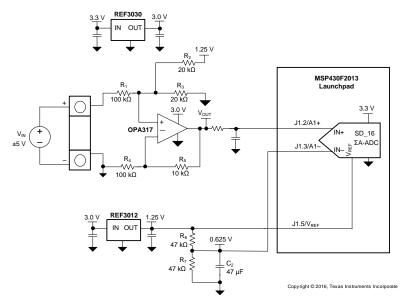


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Figure 29. Typical Connections for Operating REF30xx

9.2 Typical Application

Figure 30 shows a low-power reference and conditioning circuit. This circuit attenuates and level-shifts a bipolar input voltage within the proper input range of a single-supply low power 16-Bit $\Delta\Sigma$ ADC, such as the one inside the MSP430 or other similar single-supply ADCs. Precision reference circuits are used to level-shift the input signal, provide the ADC reference voltage and to create a well-regulated supply voltage for the low-power analog circuitry. A low-power, zero-drift, op-amp circuit is used to attenuate and level-shift the input signal.





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Typical Application (continued)

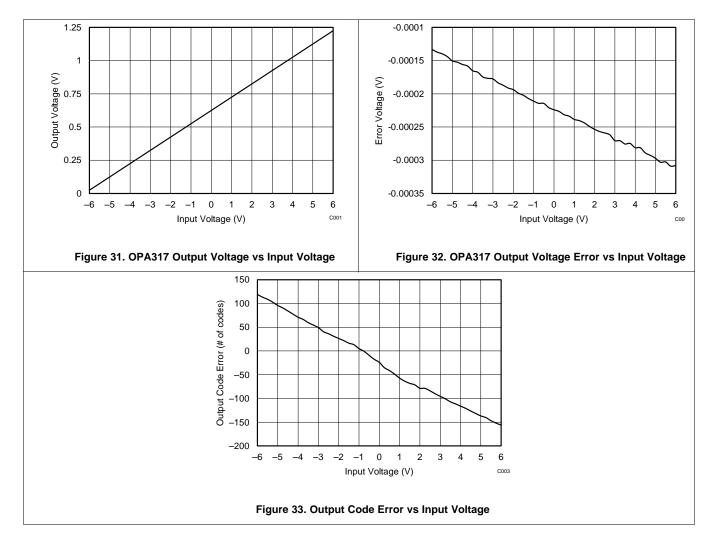
9.2.1 Design Requirements

- Supply Voltage: 3.3 V
- Maximum Input Voltage: ±6 V
- Specified Input Voltage: ±5 V
- ADC Reference Voltage: 1.25 V

The goal for this design is to accurately condition a \pm 5-V bipolar input voltage into a voltage suitable for conversion by a low-voltage ADC with a 1.25-V reference voltage, V_{REF}, and an input voltage range of V_{REF} / 2. The circuit should function with reduced performance over a wider input range of at least \pm 6 V to allow for easier protection of overvoltage conditions.

9.2.2 Detailed Design Procedure

Figure 30 depicts a simplified schematic for this design showing the MSP430 ADC inputs and full input conditioning circuitry. The ADC is configured for a bipolar measurement where final conversion result is the differential voltage between the voltage at the positive and negative ADC inputs. The bipolar, GND-referenced input signal must be level-shifted and attenuated by the op amp so that the output is biased to VREF / 2 and has a differential voltage that is within the ±VREF / 2 input range of the ADC.



9.2.3 Application Curves



10 Power Supply Recommendations

The REF30xx family of references feature an extremely low-dropout voltage. These references can be operated with a supply of only 50 mV above the output voltage. For loaded reference conditions, a typical dropout voltage versus load is shown in the front page plot, *Dropout Voltage vs Load Current*. Use a supply bypass capacitor greater than 0.47 µF.

11 Layout

11.1 Layout Guidelines

Figure 34 illustrates an example of a printed-circuit board (PCB) layout using the REF30xx. Some key considerations are:

- Connect low-ESR, 0.1- μ F ceramic bypass capacitors at V_{IN} of the REF30xx
- · Decouple other active devices in the system per the device specifications
- Use a solid ground plane to help distribute heat and reduces electromagnetic interference (EMI) noise pickup
- Place the external components as close to the device as possible. This configuration prevents parasitic errors (such as the Seebeck effect) from occurring
- Minimize trace length between the reference and bias connections to the INA and ADC to reduce noise pickup
- Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if
 possible, and only make perpendicular crossings when absolutely necessary

11.2 Layout Example

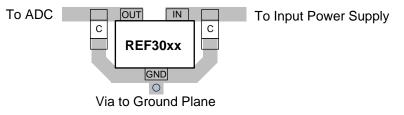


Figure 34. Layout Example

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12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

CMOS, Rail-to-Rail, I/O Operational Amplifiers (SBOS180) REF29xx 100 ppm/°C, 50 μA in 3-Pin SOT-23 CMOS Voltage Reference (SBVS033)

12.2 Related Links

Table 1 lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
REF3012	Click here	Click here	Click here	Click here	Click here
REF3020	Click here	Click here	Click here	Click here	Click here
REF3025	Click here	Click here	Click here	Click here	Click here
REF3030	Click here	Click here	Click here	Click here	Click here
REF3033	Click here	Click here	Click here	Click here	Click here
REF3040	Click here	Click here	Click here	Click here	Click here

Table 1. Related Links

12.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

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TI E2E[™] Online Community *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.5 Trademarks

E2E is a trademark of Texas Instruments. All other trademarks are the property of their respective owners.

12.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.7 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

18 Submit Documentation Feedback



13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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13-May-2016

PACKAGING INFORMATION

Orderable Device	Status	Package Type		Pins		Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
REF3012AIDBZR	ACTIVE	SOT-23	DBZ	3	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30A	Samples
REF3012AIDBZRG4	ACTIVE	SOT-23	DBZ	3	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30A	Samples
REF3012AIDBZT	ACTIVE	SOT-23	DBZ	3	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30A	Samples
REF3012AIDBZTG4	ACTIVE	SOT-23	DBZ	3	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30A	Samples
REF3020AIDBZR	ACTIVE	SOT-23	DBZ	3	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30B	Samples
REF3020AIDBZRG4	ACTIVE	SOT-23	DBZ	3	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30B	Samples
REF3020AIDBZT	ACTIVE	SOT-23	DBZ	3	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30B	Samples
REF3020AIDBZTG4	ACTIVE	SOT-23	DBZ	3	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30B	Samples
REF3025AIDBZR	ACTIVE	SOT-23	DBZ	3	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30C	Samples
REF3025AIDBZRG4	ACTIVE	SOT-23	DBZ	3	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30C	Samples
REF3025AIDBZT	ACTIVE	SOT-23	DBZ	3	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30C	Samples
REF3025AIDBZTG4	ACTIVE	SOT-23	DBZ	3	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30C	Samples
REF3030AIDBZR	ACTIVE	SOT-23	DBZ	3	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30F	Samples
REF3030AIDBZRG4	ACTIVE	SOT-23	DBZ	3	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30F	Samples
REF3030AIDBZT	ACTIVE	SOT-23	DBZ	3	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30F	Samples
REF3030AIDBZTG4	ACTIVE	SOT-23	DBZ	3	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30F	Samples
REF3033AIDBZR	ACTIVE	SOT-23	DBZ	3	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30D	Samples



13-May-2016

Orderable Device	Status	Package Type	•	Pins	Package		Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
REF3033AIDBZRG4	ACTIVE	SOT-23	DBZ	3	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30D	Samples
REF3033AIDBZT	ACTIVE	SOT-23	DBZ	3	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30D	Samples
REF3033AIDBZTG4	ACTIVE	SOT-23	DBZ	3	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30D	Samples
REF3040AIDBZR	ACTIVE	SOT-23	DBZ	3	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30E	Samples
REF3040AIDBZRG4	ACTIVE	SOT-23	DBZ	3	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30E	Samples
REF3040AIDBZT	ACTIVE	SOT-23	DBZ	3	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30E	Samples
REF3040AIDBZTG4	ACTIVE	SOT-23	DBZ	3	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	R30E	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



PACKAGE OPTION ADDENDUM

13-May-2016

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF REF3033 :

Automotive: REF3033-Q1

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

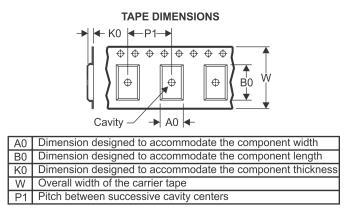
PACKAGE MATERIALS INFORMATION

www.ti.com

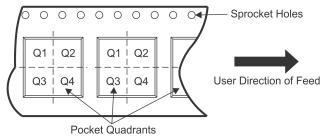
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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nomina		-						-		-	-	
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
REF3012AIDBZR	SOT-23	DBZ	3	3000	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3012AIDBZT	SOT-23	DBZ	3	250	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3020AIDBZR	SOT-23	DBZ	3	3000	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3020AIDBZT	SOT-23	DBZ	3	250	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3025AIDBZR	SOT-23	DBZ	3	3000	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3025AIDBZT	SOT-23	DBZ	3	250	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3030AIDBZR	SOT-23	DBZ	3	3000	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3030AIDBZT	SOT-23	DBZ	3	250	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3033AIDBZR	SOT-23	DBZ	3	3000	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3033AIDBZT	SOT-23	DBZ	3	250	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3040AIDBZR	SOT-23	DBZ	3	3000	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3
REF3040AIDBZT	SOT-23	DBZ	3	250	179.0	8.4	3.15	2.95	1.22	4.0	8.0	Q3

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PACKAGE MATERIALS INFORMATION

3-Aug-2017



*All dimensions are nominal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
REF3012AIDBZR	SOT-23	DBZ	3	3000	203.0	203.0	35.0
REF3012AIDBZT	SOT-23	DBZ	3	250	203.0	203.0	35.0
REF3020AIDBZR	SOT-23	DBZ	3	3000	203.0	203.0	35.0
REF3020AIDBZT	SOT-23	DBZ	3	250	203.0	203.0	35.0
REF3025AIDBZR	SOT-23	DBZ	3	3000	203.0	203.0	35.0
REF3025AIDBZT	SOT-23	DBZ	3	250	203.0	203.0	35.0
REF3030AIDBZR	SOT-23	DBZ	3	3000	203.0	203.0	35.0
REF3030AIDBZT	SOT-23	DBZ	3	250	203.0	203.0	35.0
REF3033AIDBZR	SOT-23	DBZ	3	3000	203.0	203.0	35.0
REF3033AIDBZT	SOT-23	DBZ	3	250	203.0	203.0	35.0
REF3040AIDBZR	SOT-23	DBZ	3	3000	203.0	203.0	35.0
REF3040AIDBZT	SOT-23	DBZ	3	250	203.0	203.0	35.0

DBZ 3

GENERIC PACKAGE VIEW

SOT-23 - 1.12 mm max height SMALL OUTLINE TRANSISTOR



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



4203227/C

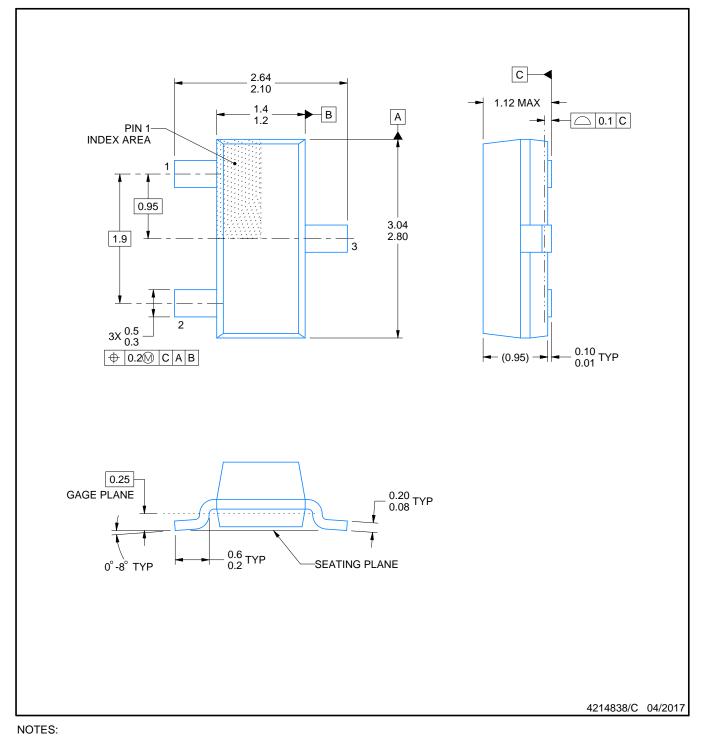
DBZ0003A



PACKAGE OUTLINE

SOT-23 - 1.12 mm max height

SMALL OUTLINE TRANSISTOR



All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 This drawing is subject to change without notice.
 Reference JEDEC registration TO-236, except minimum foot length.

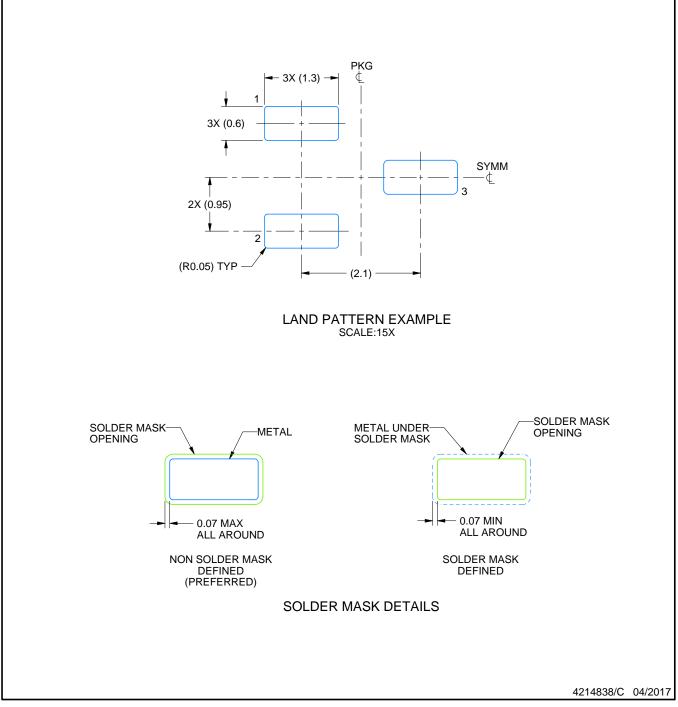


DBZ0003A

EXAMPLE BOARD LAYOUT

SOT-23 - 1.12 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

4. Publication IPC-7351 may have alternate designs.5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

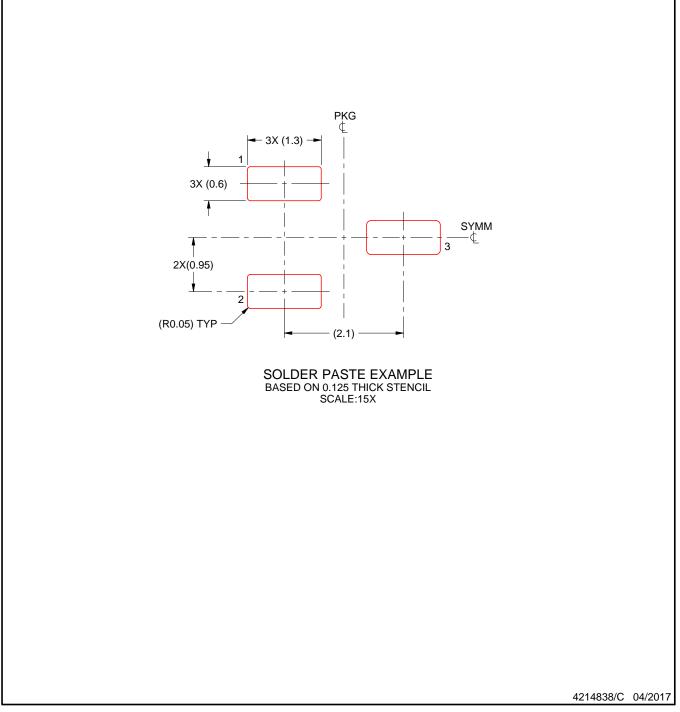


DBZ0003A

EXAMPLE STENCIL DESIGN

SOT-23 - 1.12 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

7. Board assembly site may have different recommendations for stencil design.



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